

Notice of References Cited	Application/Control No. 10/736,698		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner GERMAN VIANA DI PRISCO		Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0148780 A1	08-2003	Takano, Michiaki	455/522
	B	US-			
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FOREIGN PATENT DOCUMENTS

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